

SANYO Semiconductors

DATA SHEET



N-Channel Silicon MOSFET

MCH6412 — General-Purpose Switching Device **Applications**

Features

· Low ON-resistance.

• 1.8V drive.

Specifications

Absolute Maximum Ratings at Ta=25°C

Parameter	Symbol	Conditions	Ratings	Unit
Drain-to-Source Voltage	VDSS		30	V
Gate-to-Source Voltage	VGSS		±10	V
Drain Current (DC)	۱D		5	A
Drain Current (Pulse)	IDP	PW≤10µs, duty cycle≤1%	20	Α
Allowable Power Dissipation	PD	Mounted on a ceramic board (900mm ² X0.8mm)	1.5	W
Channel Temperature	Tch		150	°C
Storage Temperature	Tstg		-55 to +150	°C

Electrical Characteristics at Ta=25°C

Parameter	Symbol	Conditions	Ratings			1.1
			min	typ	max	Unit
Drain-to-Source Breakdown Voltage	V(BR)DSS	ID=1mA, VGS=0V	30			V
Zero-Gate Voltage Drain Current	IDSS	V _{DS} =30V, V _{GS} =0V			1	μA
Gate-to-Source Leakage Current	IGSS	V _{GS} =±8V, V _{DS} =0V			±10	μΑ
Cutoff Voltage	VGS(off)	VDS=10V, ID=1mA	0.4		1.3	V
Forward Transfer Admittance	yfs	V _{DS} =10V, I _D =3A	4.4	7.4		S
Static Drain-to-Source On-State Resistance	R _{DS} (on)1	ID=3A, VGS=4V		31	41	mΩ
	RDS(on)2	ID=1.5A, VGS=2.5V		40	57	mΩ
	R _{DS} (on)3	ID=0.3A, VGS=1.8V		55	90	mΩ
Input Capacitance	Ciss	V _{DS} =10V, f=1MHz		790		pF
Output Capacitance	Coss	VDS=10V, f=1MHz		125		pF
Reverse Transfer Capacitance	Crss	V _{DS} =10V, f=1MHz		110		pF
Turn-ON Delay Time	t _d (on)	See specified Test Circuit.		16.5		ns
Rise Time	tr	See specified Test Circuit.		78		ns
Turn-OFF Delay Time	t _d (off)	See specified Test Circuit.		77		ns
Fall Time	tf	See specified Test Circuit.		125		ns

Marking : KL

Continued on next page.

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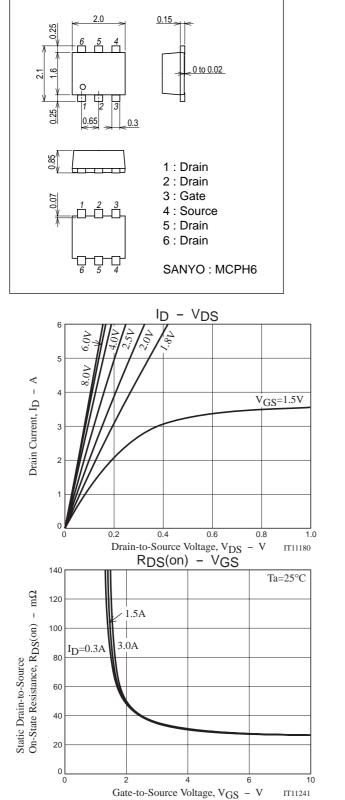
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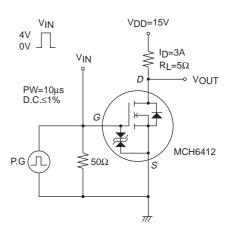
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Parameter	Symbol	Conditions	Ratings			Unit
	Symbol		min	typ	max	Unit
Total Gate Charge	Qg	VDS=10V, VGS=4V, ID=5A		7.0		nC
Gate-to-Source Charge	Qgs	V _{DS} =10V, V _{GS} =4V, I _D =5A		1.8		nC
Gate-to-Drain "Miller" Charge	Qgd	VDS=10V, VGS=4V, ID=5A		1.9		nC
Diode Forward Voltage	VSD	IS=5A, VGS=0V		0.86	1.2	V

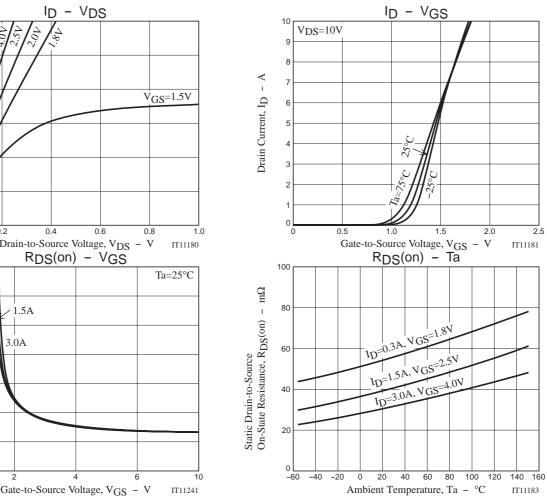
Package Dimensions

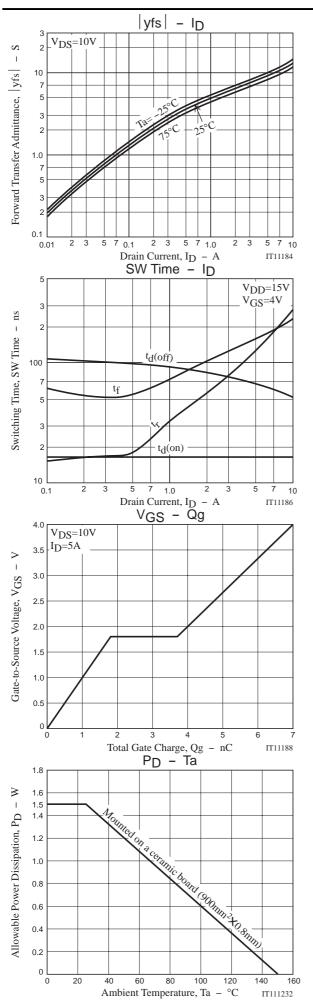
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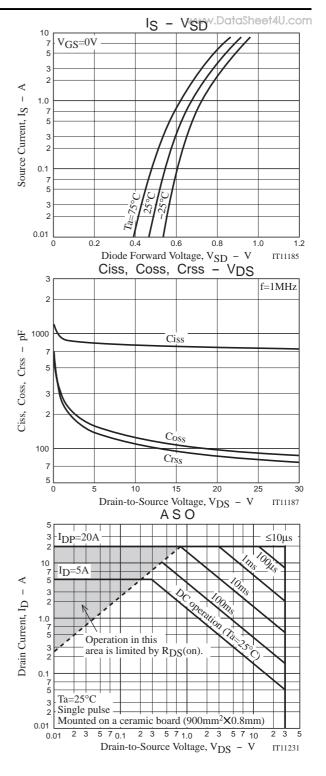


Switching Time Test Circuit









Note on usage : Since the MCH6412 is a MOSFET product, please avoid using this device in the vicinity of highly charged objects.

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